

Common-Drain Dual N-Channel MOSFET

■ DESCRIPTION

SMC4272 is the Dual N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced trench technology to provide excellent $R_{DS(ON)}$. These devices are well suited for high efficiency fast switching applications, low in-line power loss are needed in small outline surface mount package.

■ PART NUMBER INFORMATION

SMC 4272 S6 - TR G

a b c d e

a : Company name.

b : Product Serial number.

c : Package code S6:SOT-23-6L

d : Handling code TR:Tape&Reel

e : Green produce code G:*RoHS Compliant*

■ FEATURES

$$V_{DS} = 20V, \quad I_D = 6.5A$$

$$R_{DS(ON)} = 18m\Omega (\text{Typ.}) @ V_{GS} = 4.5V$$

$$R_{DS(ON)} = 19m\Omega (\text{Typ.}) @ V_{GS} = 4.0V$$

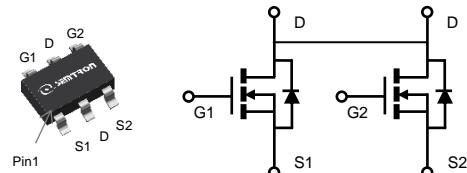
$$R_{DS(ON)} = 20m\Omega (\text{Typ.}) @ V_{GS} = 3.2V$$

$$R_{DS(ON)} = 22m\Omega (\text{Typ.}) @ V_{GS} = 2.5V$$

- ◆ Fast switch
- ◆ High power and current handling capability
- ◆ Exceptional on-resistance

■ APPLICATIONS

- ◆ Power Management in Notebook Computer
- ◆ Portable Equipment and Battery Powered



SOT-23-6L

■ ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-Source Voltage	20	V
V_{GSS}	Gate-Source Voltage	± 12	V
I_D	Continuous Drain Current ^A	$T_A=25^\circ\text{C}$	A
		$T_A=70^\circ\text{C}$	A
I_{DM}	Pulsed Drain Current ^B	26	A
P_D	Power Dissipation ^A	$T_A=25^\circ\text{C}$	W
		$T_A=70^\circ\text{C}$	W
T_J	Operation Junction Temperature	-55/150	$^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55/150	$^\circ\text{C}$

■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^C	$t \leq 10\text{s}$	75	90
	Thermal Resistance Junction to Ambient ^C		115	130
$R_{\theta JC}$	Thermal Resistance Junction to Case ^C	Steady-State	65	80

ELECTRICAL CHARACTERISTICS($T_A = 25^\circ\text{C}$ Unless otherwise noted)

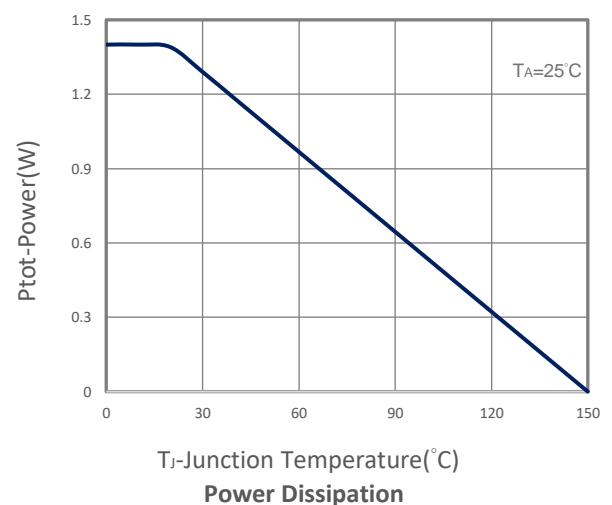
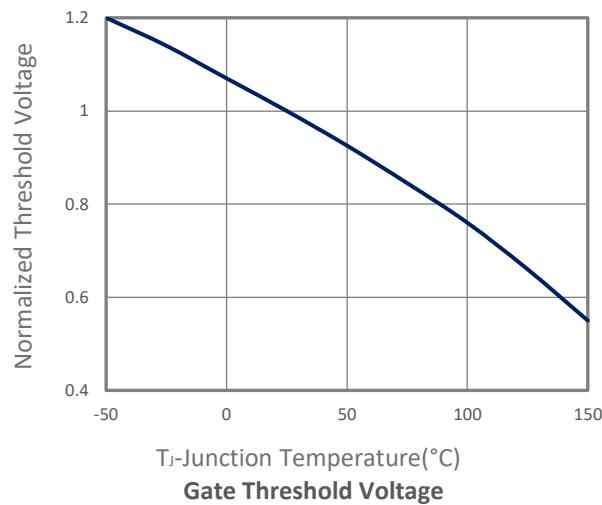
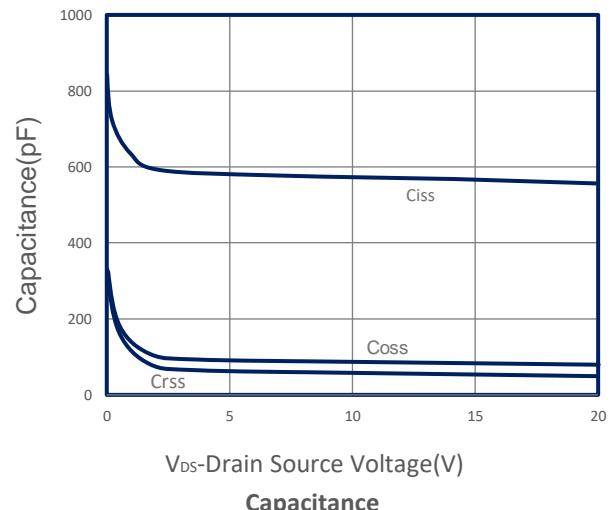
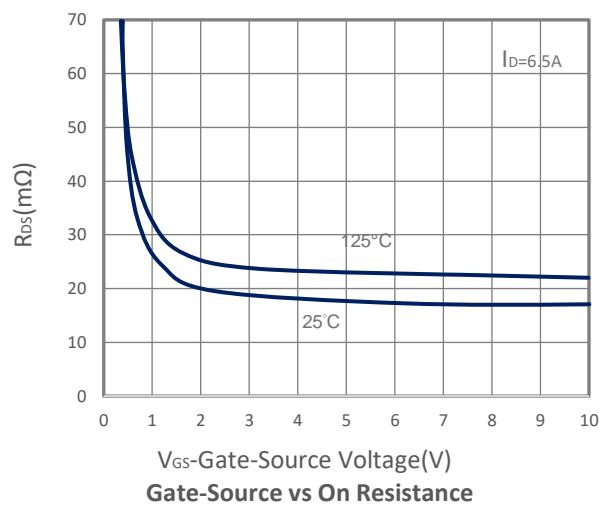
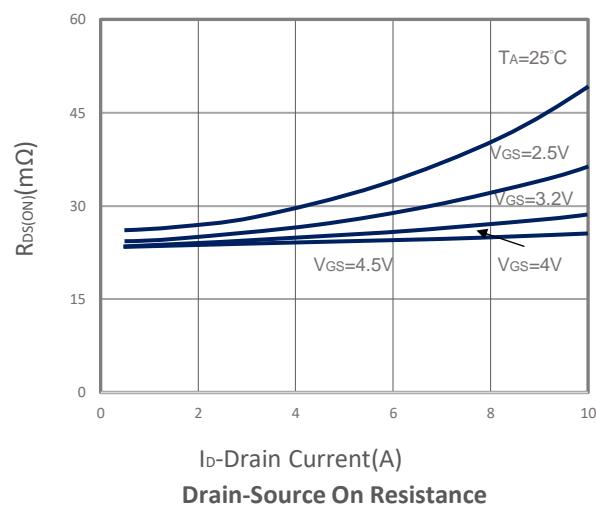
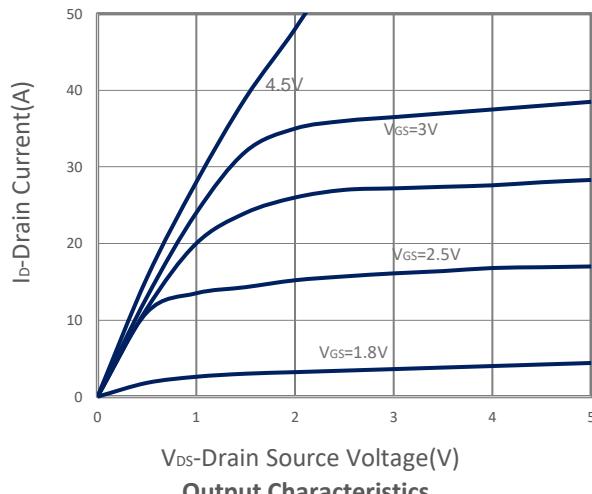
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	20			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.4	0.6	1.0	V	
I_{GSS}	Gate Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 12\text{V}$			± 100	nA	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$ $T_J = 25^\circ\text{C}$			1	μA	
		$V_{DS} = 16\text{V}, V_{GS} = 0\text{V}$ $T_J = 75^\circ\text{C}$			10		
$R_{DS(\text{ON})}$	Drain-source On-Resistance ^D	$V_{GS} = 4.5\text{V}, I_D = 6.5\text{A}$		18	22	$\text{m}\Omega$	
		$V_{GS} = 4.0\text{V}, I_D = 5.0\text{A}$		19	23		
		$V_{GS} = 3.2\text{V}, I_D = 4.0\text{A}$		20	24		
		$V_{GS} = 2.5\text{V}, I_D = 3.0\text{A}$		22	26		
G_f	Forward Transconductance	$V_{DS} = 5\text{V}, I_D = 5.2\text{A}$		13		S	
Diode Characteristics							
V_{SD}	Diode Forward Voltage ^D	$I_S = 1\text{A}, V_{GS} = 0\text{V}$		0.7	1	V	
I_S	Continuous Source Current				6	A	
t_{rr}	Body Diode Reverse Recovery Time	$V_{DD} = 10\text{V}, T_J = 25^\circ\text{C}$ $I_S = 6.5\text{A}, dI/dt = 100\text{A}/\mu\text{s}$		21		ns	
Q_{rr}	Body Diode Reverse Recovery Charge			10		nC	
Dynamic Parameters							
Q_g	Total Gate Charge	$V_{DS} = 10\text{V}, V_{GS} = 4.5\text{V}$ $I_D = 6.5\text{A}$		6.2	8.2	nC	
Q_{gs}	Gate-Source Charge			2.2	3.0		
Q_{gd}	Gate-Drain Charge			1.75	2.3		
C_{iss}	Input Capacitance	$V_{DS} = 10\text{V}, V_{GS} = 0\text{V}$ $f = 1\text{MHz}$		572	709	pF	
C_{oss}	Output Capacitance			72	90		
C_{rss}	Reverse Transfer Capacitance			38	45		
$t_{d(on)}$	Turn-On Time ^E	$V_{DD} = 10\text{V}, V_{GEN} = 4.5\text{V}$, $R_G = 3\Omega, I_D = 1\text{A}$		6.7		nS	
t_r				6			
$t_{d(off)}$	Turn-Off Time ^E			12.2			
t_f				5			

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

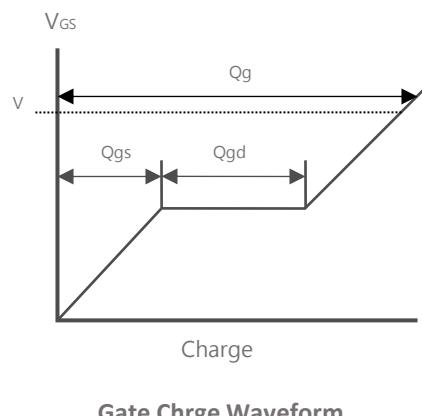
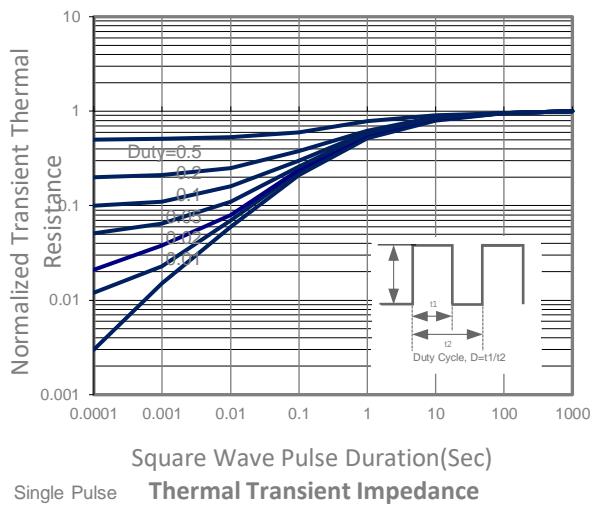
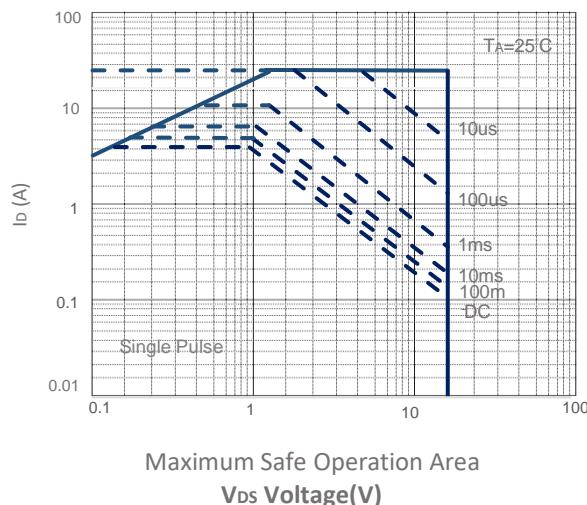
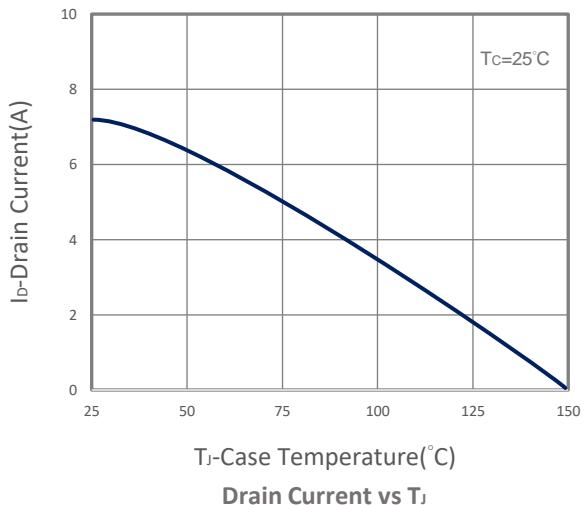
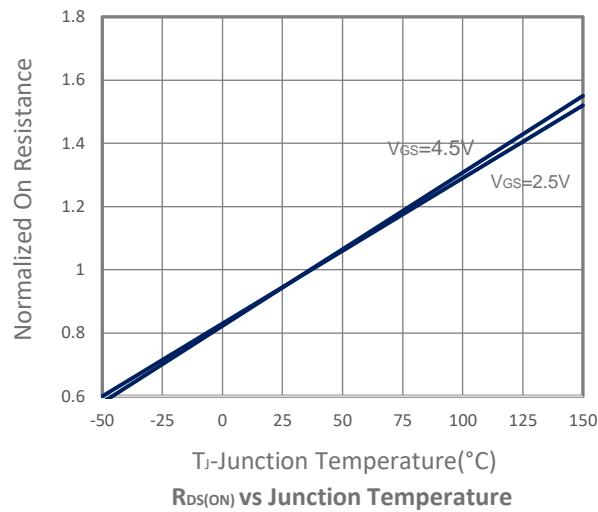
- A. The value of $R_{\theta JA}$ is measured with the device in a still air environment with maximum junction temperature $T_J(\text{MAX}) = 150^\circ\text{C}$ (initial temperature $T_A = 25^\circ\text{C}$).
- B. The $T_J(\text{MAX}) = 150^\circ\text{C}$, using junction-to-ambient thermal resistance.
- C. Surface-mounted on FR-4 board using 1 sq-in pad, 2 oz Cu, in a still air environment with $T_A = 25^\circ\text{C}$.
- D. The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- E. Pulsed width limited by maximum junction temperature.

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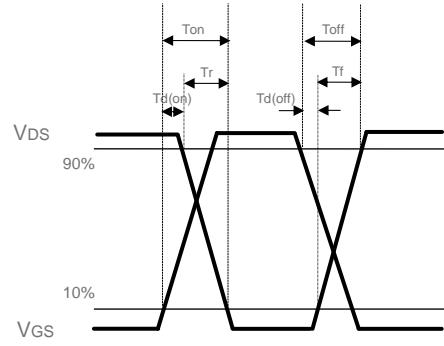
TYPICAL CHARACTERISTICS



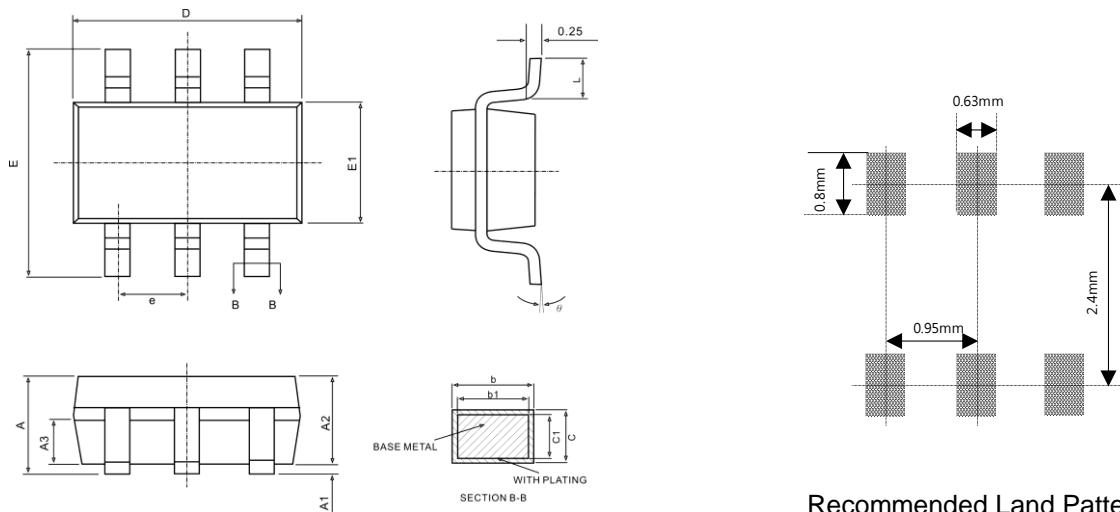
TYPICAL CHARACTERISTICS



Gate Charge Waveform



Switching Time Waveform

SOT-23-6L PACKAGE DIMENSIONS


Recommended Land Pattern

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	-	1.300	-	0.051
A1	0.040	0.100	0.002	0.004
A2	1.000	1.200	0.039	0.047
A3	0.550	0.750	0.022	0.030
b	0.340	0.430	0.013	0.017
b1	0.330	0.380	0.013	0.015
c	0.150	0.210	0.006	0.008
c1	0.140	0.160	0.006	0.006
D	2.720	3.120	0.107	0.123
E	2.600	3.000	0.102	0.118
E1	1.400	1.800	0.055	0.071
e	0.950 BSC		0.066 BSC	
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°